

Notice of References Cited	Application/Control No. 10/816,554	Applicant(s)/Patent Under Reexamination ARZENO ET AL.	
	Examiner Deepak Rao	Art Unit 1624	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,492,792	01-1985	Fujii et al.	544/326
	B	US-			
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	D	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 61083168 A	04-1986	Japan	YOSHIDA et al.	-----
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	English Abstract of JP 61083168 A, 1986.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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